

## ZXMN10A07FTC-VB Datasheet

### N-Channel 100 V (D-S) MOSFET

#### MOSFET PRODUCT SUMMARY

$V_{DS}$ (V)	$R_{DS(on)}$ ( $\Omega$ )	$I_D$ (A) <sup>a</sup>	$Q_g$ (Typ.)
100	0.240 at $V_{GS} = 10$ V	2.0	2.9 nC
	0.250 at $V_{GS} = 6$ V	1.8	
	0.260 at $V_{GS} = 4.5$ V	1.7	

#### FEATURES

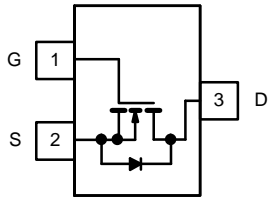
- Trench Power MOSFET
- 100 %  $R_g$  Tested
- 100 % UIS Tested
- Material categorization:



**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**

#### APPLICATIONS

- DC/DC Converters
- Load Switch
- LED Backlighting in LCD TVs



#### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25$ °C, unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current ( $T_J = 150$ °C)	$T_C = 25$ °C	2	A
	$T_C = 70$ °C	1.8	
	$T_A = 25$ °C	1.6 <sup>b, c</sup>	
	$T_A = 70$ °C	1.3 <sup>b, c</sup>	
Pulsed Drain Current ( $t = 300$ $\mu$ s)	$I_{DM}$	7	
Continuous Source-Drain Diode Current	$T_C = 25$ °C	2.1	
	$T_A = 25$ °C	1.0 <sup>b, c</sup>	
Single Pulse Avalanche Current	$I_{AS}$	5	
Single Pulse Avalanche Energy	$E_{AS}$	1.25	mJ
Maximum Power Dissipation	$T_C = 25$ °C	2.5	W
	$T_C = 70$ °C	1.6	
	$T_A = 25$ °C	1.25 <sup>b, c</sup>	
	$T_A = 70$ °C	0.8 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	- 55 to 150	°C

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b, d</sup>	$R_{thJA}$	75	100	°C/W
Maximum Junction-to-Foot (Drain)	$R_{thJF}$	40	50	

Notes:

a. Based on  $T_C = 25$  °C.

b. Surface mounted on 1" x 1" FR4 board.

c.  $t = 5$  s.

d. Maximum under steady state conditions is 166 °C/W.



MOSFET SPECIFICATIONS (T <sub>J</sub> = 25 °C, unless otherwise noted)											
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit					
Static											
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>DS</sub> = 0 V, I <sub>D</sub> = 250 μA	100			V					
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA		105		mV/°C					
V <sub>GS(th)</sub> Temperature Coefficient	ΔV <sub>GS(th)</sub> /T <sub>J</sub>			- 5.2							
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	1.2		2.8	V					
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ± 20 V			± 100	nA					
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V			- 1	μA					
		V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10						
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≥ 5 V, V <sub>GS</sub> = 4.5 V	5			A					
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.5 A		0.240		Ω					
		V <sub>GS</sub> = 6 V, I <sub>D</sub> = 1 A		0.250							
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 0.5 A		0.260							
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 1.5 A		2.0		S					
Dynamic <sup>b</sup>											
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V, f = 1 MHz		190		pF					
Output Capacitance	C <sub>oss</sub>			22							
Reverse Transfer Capacitance	C <sub>rss</sub>			13							
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.6 A		5.2	10.4	nC					
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 1.6 A		2.9	5.8						
Gate-Drain Charge	Q <sub>gd</sub>			0.75							
Gate Resistance	R <sub>g</sub>			1.4							
Turn-On Delay Time	t <sub>d(on)</sub>	f = 1 MHz	0.3	1.4	2.8	Ω					
Rise Time	t <sub>r</sub>										
Turn-Off Delay Time	t <sub>d(off)</sub>										
Fall Time	t <sub>f</sub>										
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 50 V, R <sub>L</sub> = 39 Ω I <sub>D</sub> = 1.3 A, V <sub>GEN</sub> = 4.5 V, R <sub>g</sub> = 1 Ω		30	45	ns					
Rise Time	t <sub>r</sub>						V <sub>DD</sub> = 50 V, R <sub>L</sub> = 39 Ω I <sub>D</sub> = 1.3 A, V <sub>GEN</sub> = 10 V, R <sub>g</sub> = 1 Ω	6	12		
Turn-Off Delay Time	t <sub>d(off)</sub>									10	20
Fall Time	t <sub>f</sub>										
Turn-On Delay Time	t <sub>d(on)</sub>	6	12								
Rise Time	t <sub>r</sub>										
Turn-Off Delay Time	t <sub>d(off)</sub>										
Fall Time	t <sub>f</sub>										
Drain-Source Body Diode Characteristics											
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 2.1	A					
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 20						
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1.3 A		- 0.8	- 1.2	V					
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 1.3 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		22	33	ns					
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			21	32	nC					
Reverse Recovery Fall Time	t <sub>a</sub>			16		ns					
Reverse Recovery Rise Time	t <sub>b</sub>			6							

Notes:

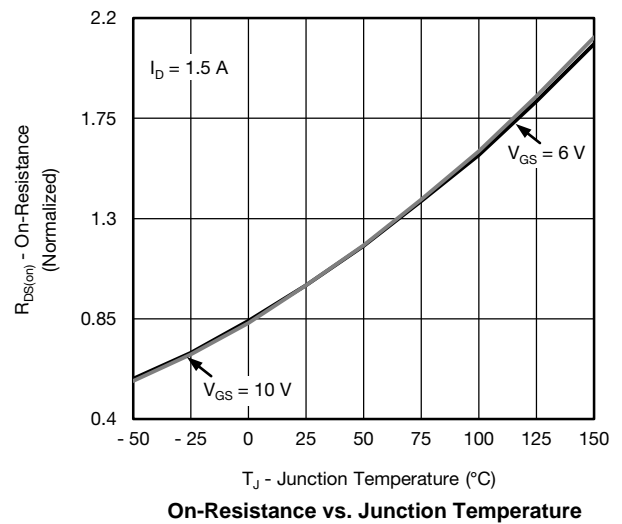
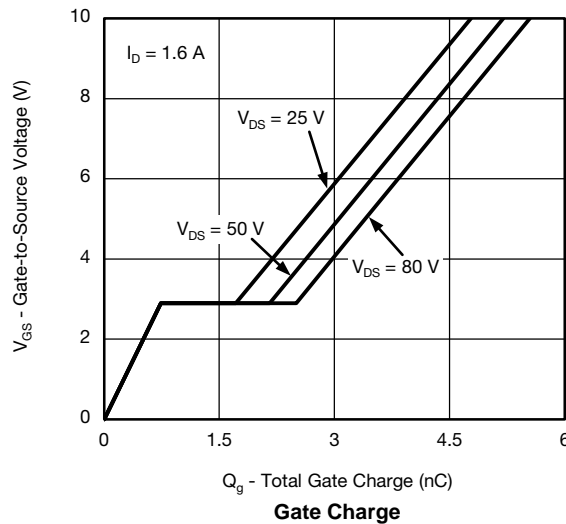
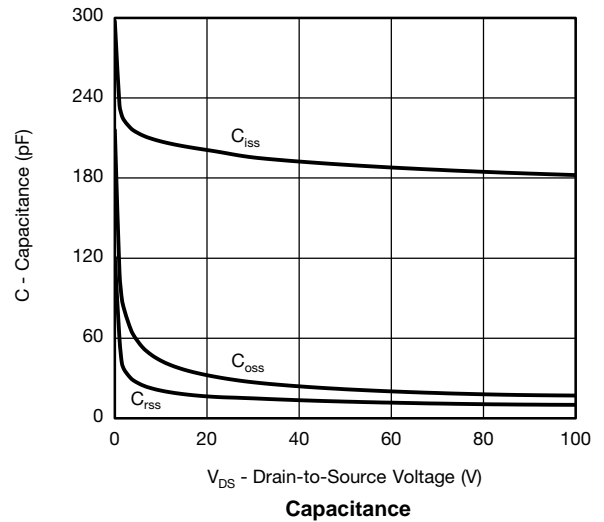
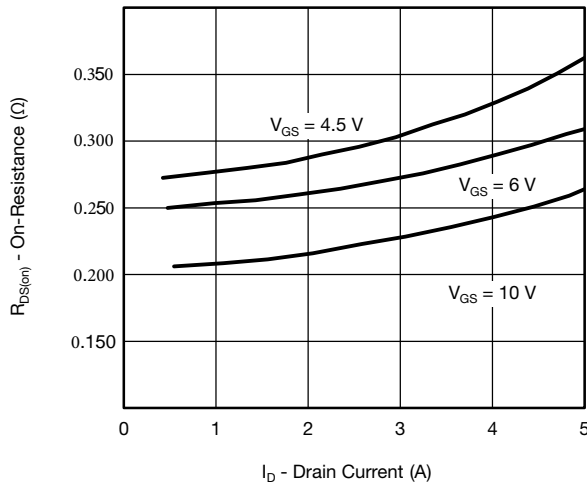
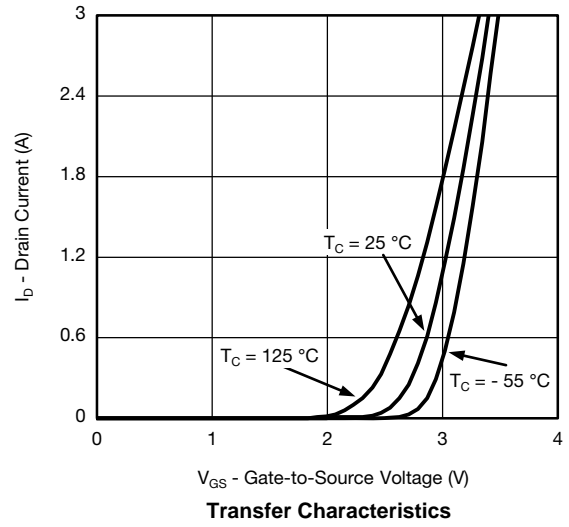
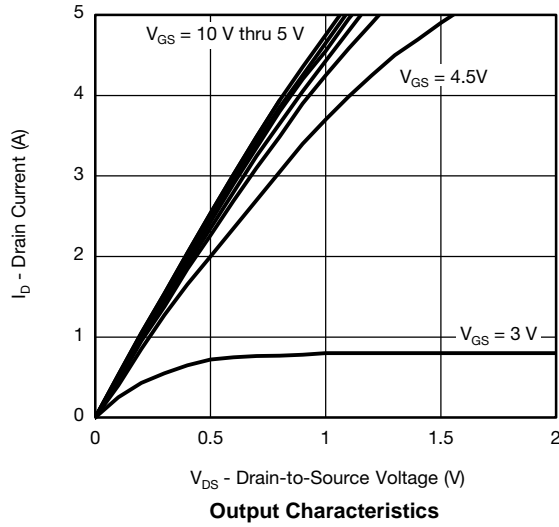
a. Pulse test; pulse width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

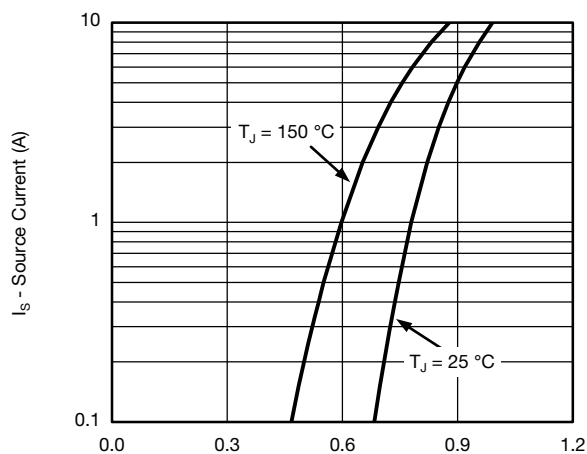


**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

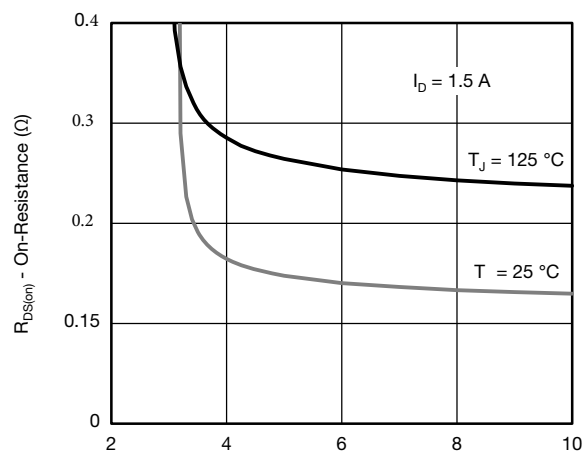




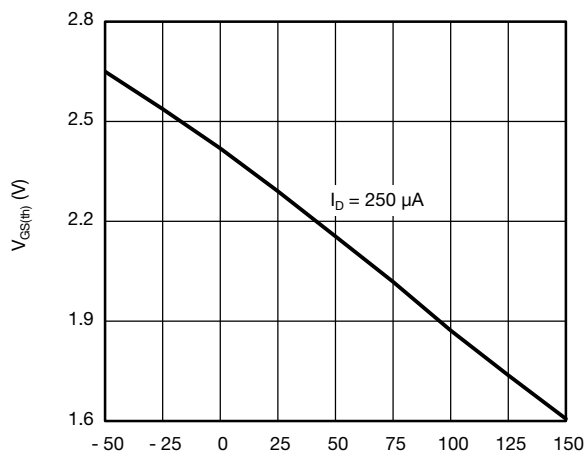
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



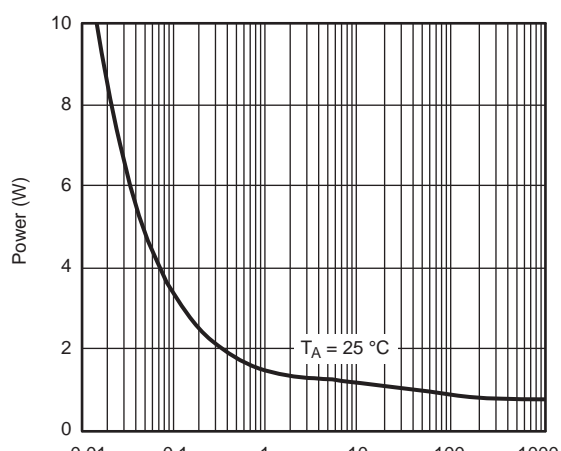
Source-Drain Diode Forward Voltage



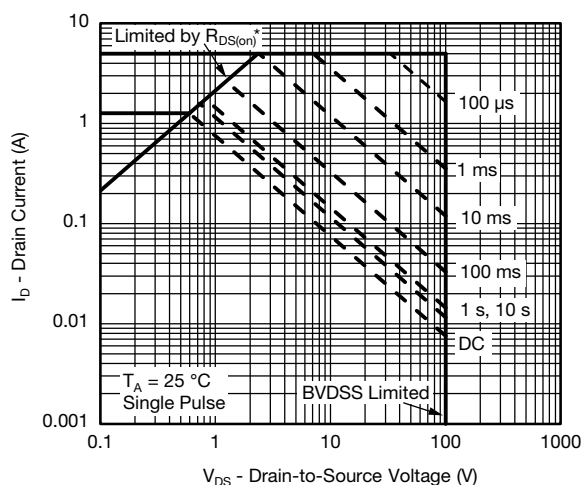
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power

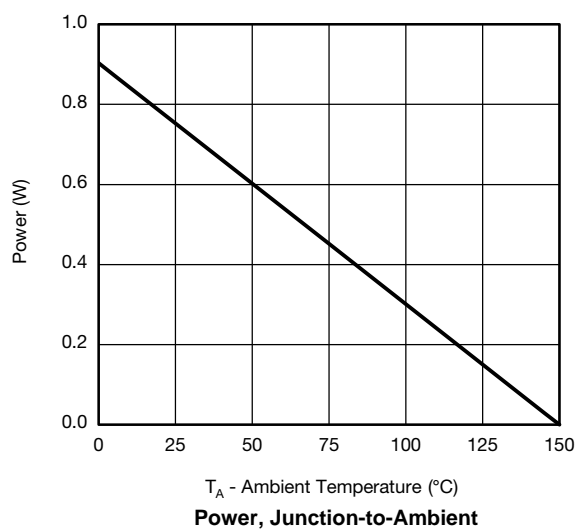
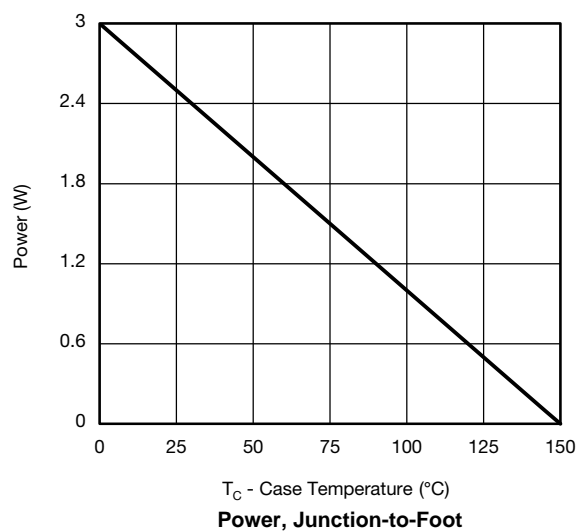
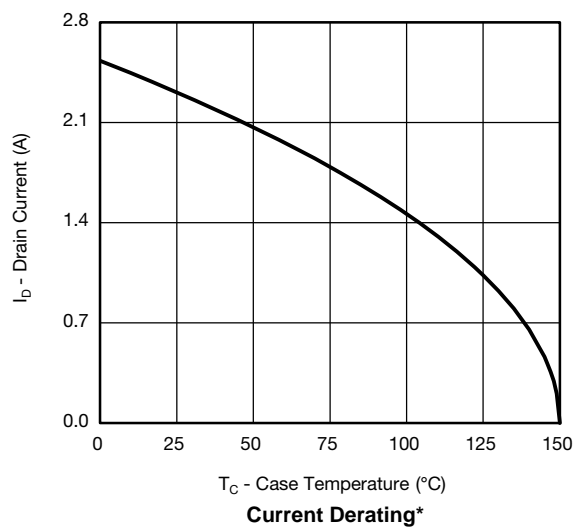


\*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area



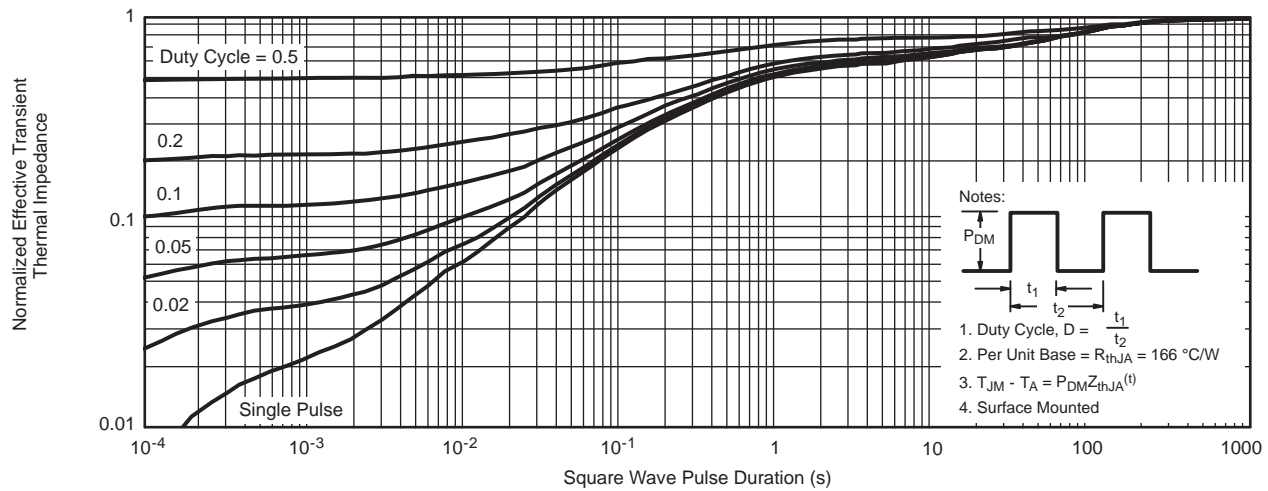
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



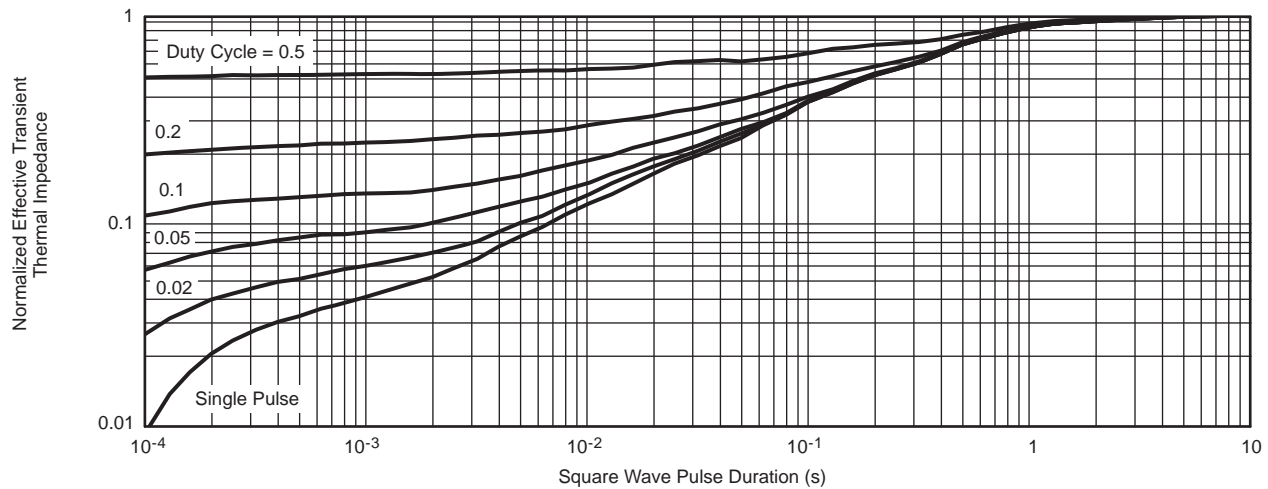
\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



**THERMAL RATINGS** ( $T_A = 25\text{ }^{\circ}\text{C}$ , unless otherwise noted)



**Normalized Thermal Transient Impedance, Junction-to-Ambient**



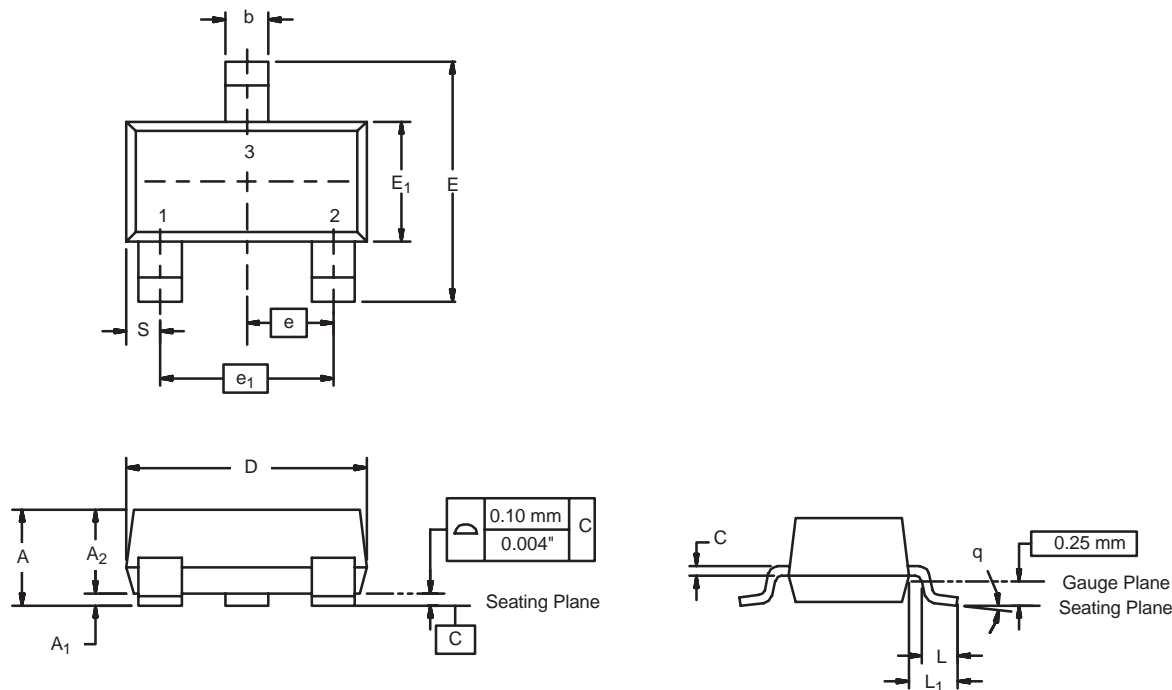
**Normalized Thermal Transient Impedance, Junction-to-Foot**

**Note**

- The characteristics shown in the two graphs
    - Normalized Transient Thermal Impedance Junction-to-Ambient ( $25\text{ }^{\circ}\text{C}$ )
    - Normalized Transient Thermal Impedance Junction-to-Foot ( $25\text{ }^{\circ}\text{C}$ )
- are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



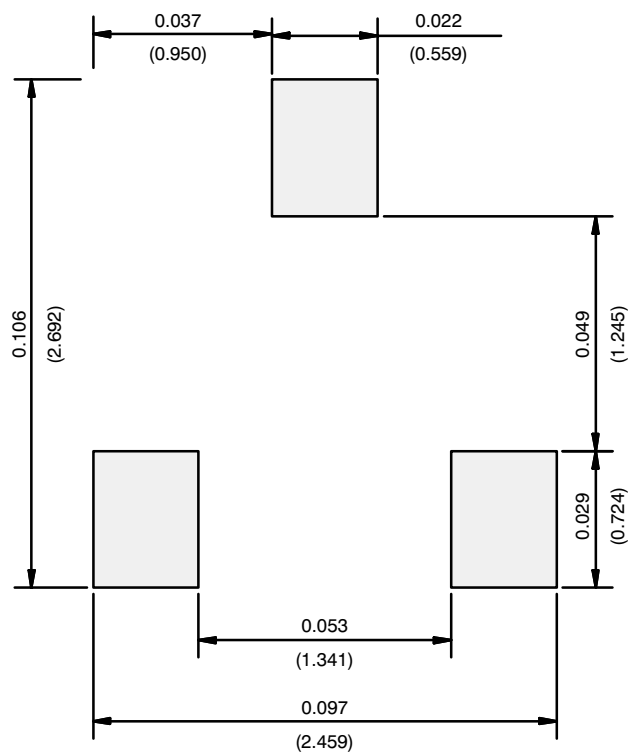
SOT-23 (TO-236): 3-LEAD



Dim	MILLIMETERS		INCHES	
	Min	Max	Min	Max
A	0.89	1.12	0.035	0.044
A <sub>1</sub>	0.01	0.10	0.0004	0.004
A <sub>2</sub>	0.88	1.02	0.0346	0.040
b	0.35	0.50	0.014	0.020
c	0.085	0.18	0.003	0.007
D	2.80	3.04	0.110	0.120
E	2.10	2.64	0.083	0.104
E <sub>1</sub>	1.20	1.40	0.047	0.055
e	0.95 BSC		0.0374 Ref	
e <sub>1</sub>	1.90 BSC		0.0748 Ref	
L	0.40	0.60	0.016	0.024
L <sub>1</sub>	0.64 Ref		0.025 Ref	
S	0.50 Ref		0.020 Ref	
q	3°	8°	3°	8°
ECN: S-03946-Rev. K, 09-Jul-01 DWG: 5479				



## RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads  
Dimensions in Inches/(mm)



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